



SPEC / C/PLOT

SPEC is one of the worldwide leading solutions for the control of x-ray instruments. It is used in over 200 synchrotrons and many university labs.

Based on a simple macro language measurement algorithms are programmed. Many instruments are directly implemented or easy to control over various interfaces.

Huber supplies you with preconfigured workstations for the control of diffractometers.

For more information see www.certif.com

